

<b>Notice of References Cited</b>		Application/Control No. 10/814,715	Applicant(s)/Patent Under Reexamination SHAN ET AL.	
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**U.S. PATENT DOCUMENTS**

*	Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A US-6,763,350	07-2004	Agrawal et al.	707/3
*	B US-2002/0059283	05-2002	Shapiro et al.	707/100
*	C US-6,339,769	01-2002	Cochrane et al.	707/2
*	D US-5,819,286	10-1998	Yang et al.	707/1
*	E US-6,985,903	01-2006	Biacs, Zoltan	707/100
*	F US-6,175,829	01-2001	Li et al.	707/3
*	G US-6,052,121	04-2000	Webster et al.	715/733
*	H US-2004/0177084	09-2004	Agrawal et al.	707/101
*	I US-7,260,566	08-2007	Agrawal et al.	707/3
*	J US-5,918,225	06-1999	White et al.	707/3
*	K US-5,794,229	08-1998	French et al.	707/2
*	L US-6,298,342	10-2001	Graefe et al.	707/4
M	US-			

**FOREIGN PATENT DOCUMENTS**

*	Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
N					
O					
P					
Q					
R					
S					
T					

**NON-PATENT DOCUMENTS**

*	Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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V	
W	
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